

**Notic of References Cited**

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Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0049150 A1	12-2001	Nakagawa et al.	438/8
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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